What Is Claimed Is:

1	1. A	static attitude measurement device for measuring the static	
2	attitude of a head suspe	attitude of a head suspension target while reducing measurement errors due to stray	
3	spots and internal refle	spots and internal reflections, the device comprising:	
4	a	light source for producing a light beam;	
5	a	beam splitter for directing a first portion of the light beam	
6	toward a target from which a reflected beam is returned;		
7	a	detector for detecting the reflected beam at a predetermined	
8	polarization state; and		
9	a	polarization component for producing the predetermined	
10	polarization state in the reflected beam, the polarization component positioned		
11	between the beam splitter and the target.		
1	2. T	he measurement device of claim 1, wherein the polarization	
2	component comprises a	quarter-wave plate.	
1	3. T	he measurement device of claim 2, wherein the beam	
2	splitter comprises a firs	t beam splitter and the device further comprises a second	
3	beam splitter position b	between the light source and the first beam splitter.	
1	4. T	he measurement device of claim 3, wherein the second	
2		s a polarizing beam splitter.	
1	5. T	he measurement device of claim 3, wherein the first beam	
2	splitter comprises a pol	·	
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1	6. T	he measurement device of claim 3, further comprising a	
2		ween the first and second beam splitters.	
_	positioned bet	con the that and second beam spinters.	

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1	7.	The measurement device of claim 6, further comprising a
2	beam reducer positioned between the first beam splitter and the polarizer.	
1	8.	The measurement device of claim 1, further comprising
2	collection optics posi	tioned between the beam splitter and the quarter-wave plate,
3	the collection optics i	ncluding at least one lens for focusing the first portion of the
4	beam.	
1	9.	The measurement device of claim 1, wherein the beam
2	splitter is positioned b	between the target and the detector.
1		The measurement device of claim 1, wherein the static
2	attitude measurement device also measures Z-height of the target and wherein the	
3	device further compri	ses:
4		a Z-height detector for detecting a Z-height reflected beam;
5	and	
6		a Z-height directional component for directing a second
7	portion of the light beam toward the target from which the reflected beam from the	
8	target is directed toward the Z-height detector.	
1		The measurement device of claim 10, further comprising a
2	polarization component positioned between the Z-height directional component	
3	and the target for changing the polarization state of the second portion of the light	
4	beam prior to encount	tering the target.
1		The measurement device of claim 1, wherein the light source
2	comprises a polarized	laser.

1	13. The measurement device of claim 1, wherein the detector	
2	comprises a polarizer that passes substantially only light in the predetermined	
3	polarization state.	
1	14. A method for measuring the static attitude of a head	
2	suspension target while reducing measurement errors due to stray spots and	
3	internal reflections, the method comprising the steps of:	
4	providing a light beam;	
5	directing the beam onto a target from which a reflected beam	
6	is returned;	
7	producing a predetermined polarization state in the reflected	
8	beam by passing the beam and the reflected beam through a first polarization	
9	component; and	
10	detecting the reflected beam at the predetermined	
11	polarization state.	
1	15. The method of claim 14, wherein the step of detecting	
2	comprises providing a detector that detects the reflected beam at the predetermined	
3	polarization state and providing a polarizer that passes substantially only light in	
4	the predetermined polarization state.	
1	16. The method of claim 14, wherein the first polarization	
2	component comprises a quarter-wave plate through which the beam and reflected	
3	beam are passed to produce a predetermined polarization state in the reflected	
4	beam that is orthogonally polarized with respect to a polarization state of the beam.	
1	17. The method of claim 14, wherein the step of directing	

comprises passing the beam through a beam splitter before encountering the target.

1	18. The method of claim 17, wherein the beam splitter comprises
2	a polarizing beam splitter which passes substantially only light in the
3	predetermined polarization state and reflects substantially all other light.

- 19. The method of claim 17, further comprising passing the beam through a polarizer positioned before beam splitter to substantially block light at undesired polarization states.
- 20. The method of claim 14, wherein the method is also for measuring the Z-height of the target, and wherein the method further comprises directing a portion of the beam onto the target from which a reflected Z-height beam is returned and detecting the reflected Z-height beam to determine the Z-height of the target.
- 21. The method of claim 20, further comprising the step of producing a desired polarization state in the reflected Z-height beam such that any reflected Z-height beam directed toward the detector for the static attitude measurement is not in the predetermined polarization state.
- 22. The method of claim 21, wherein the step of producing comprises passing the portion of the beam through a second polarization component before the portion of the beam encounters the target, such that any portion of the reflected Z-height beam directed toward the detector for the static attitude measurement also passes through the first polarization component producing a polarization state in the reflected Z-height beam that is substantially not the predetermined polarization state.

- 23. In a static attitude measurement device for measuring the static attitude of a head suspension target, the device including a light source for producing a light beam, first and second beam splitters for directing the light beam toward the target from which a reflected beam is returned, and a detector for detecting light at substantially only a predetermined polarization state with the detector positioned to intercept the reflected beam, the improvement comprising a quarter-wave plate positioned between the second beam splitter and the target for producing the predetermined polarization state in the reflected beam.
 - 24. The improvement of claim 23, further comprising a polarizer positioned between the first and second beam splitters for reducing light in an unwanted polarization state from reaching the quarter-wave plate and the target.
- 25. In a combined static attitude and Z-height measurement device for measuring the static attitude and Z-height of a head suspension target, the device including a light source for producing a light beam, a first beam splitter for producing first and second portions of the light beam, a second beam splitter for directing the first portion of the light beam toward the target from which a static attitude reflected beam is returned, a first detector for detecting light at substantially only a predetermined polarization state with the detector positioned to intercept the static attitude reflected beam, at least one directional component for directing the second portion of the light beam toward the target from which a Z-height reflected beam is returned and a second detector positioned to intercept and detect the Z-height reflected beam, the improvement comprising:

a first quarter-wave plate positioned between the second beam splitter and the target for producing the predetermined polarization state in the static attitude reflected beam; and

a second quarter-wave plate positioned before the target for

- producing a desired polarization state in the second portion of the light beam before it encounters the target.
- The improvement of claim 25, further comprising a polarizer positioned between the first and second beam splitters for reducing light in an unwanted polarization state from reaching the first quarter-wave plate and the target.